Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/679,351	SAITO ET AL.	
	Examiner	Art Unit	
	Chris C. Chu	2815	

SEARCHED			
Class	Subclass	Date	Examiner
257	678 and 702 - 709	3/11/2005	C.C.
361	719 & 783	3/11/2005	C.C.
361	760	3/11/2005	C.C.
174	52.1&52.3	3/11/2005	C.C.
174	52.4-52.6	3/11/2005	C.C.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Searched in US-PGPUB; PUPAT; USOCR; EPO; JPO; DERWENT; and IBM-TDB;	3/11/2005	C.C.
Consulted with John Vigushin 361/ 783 & 760 174/ 52.1 & 52.3 - 52.6	3/10/2005	C.C.